

Search Notes

Application No.

10/604,817

Examiner

Peguy JeanPierre

Applicant(s)

CHEN, YUEH-CHANG

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
341	143		
	110		
	111		
375	269		
	272	3/3/2004	PJP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
341	143		
	110		
375	269	3/3/2004	PJP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		
FSK in which pair of sample points are compared to determine sample correcting number; samples being compared are;		
symmetric to a central value; one of the pair is compared to the central value to determine sample direction	3/3/2004	PJP